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## HCPL062N

# 3.3V Dual Channel High Speed-10 MBit/s Logic Gate Optocouplers 

Features
■ Compact SO8 package
■ Very high speed - 10MBit/s
■ Superior CMR - $25 \mathrm{kV} / \mu \mathrm{s}$ minimum ( 1,000 volts common mode)

- Logic gate output

■ Wired OR-open collector

- Fixed threshold detector design minimizes thermal impact on switching times
■ U.L. recognized (File \# E90700)


## Applications

■ Ground loop elimination

- Field buses
- Line receiver, data transmission
- Data multiplexing

■ Switching power supplies
■ Pulse transformer replacement
■ Computer-peripheral interface

- Instrumentation input/output isolation


## Description

The HCPL062N optocouplers consist of an AIGaAs LED, optically coupled to a very high speed integrated photodetector logic gate consisting of bipolar transistors on a CMOS process for reduced power consumption. The output features an open collector, thereby permitting wired OR outputs. The devices are housed in a compact small-outline package. The coupled parameters are guaranteed over the temperature range of $-40^{\circ} \mathrm{C}$ to $+85^{\circ} \mathrm{C}$. An internal noise shield and provides superior common mode rejection.

## Circuit Drawing ${ }^{(1)}$



## Note:

1. The $\mathrm{V}_{C C}$ supply to each optoisolator must be bypassed by a $0.1 \mu \mathrm{~F}$ capacitor or larger. This can be either a ceramic or solid tantalum capacitor with good high frequency characteristic and should be connected no further than 3 mm from the $\mathrm{V}_{\mathrm{CC}}$ and GND pins of each device.

Absolute Maximum Ratings (No derating required up to $85^{\circ} \mathrm{C}$ )

| Symbol | Parameter | Value | Units |
| :---: | :--- | :---: | :---: |
| $\mathrm{T}_{\mathrm{STG}}$ | Storage Temperature | -40 to +125 | ${ }^{\circ} \mathrm{C}$ |
| $\mathrm{T}_{\mathrm{OPR}}$ | Operating Temperature | -40 to +85 | ${ }^{\circ} \mathrm{C}$ |
| EMITTER |  | 50 | mA |
| $\mathrm{I}_{\mathrm{F}}$ | DC/Average Forward Input Current (each channel) | 5.0 | V |
| $\mathrm{~V}_{\mathrm{R}}$ | Reverse Input Voltage (each channel) | 45 | mW |
| $\mathrm{P}_{\mathrm{I}}$ | Power Dissipation |  |  |
| DETECTOR |  | 7.0 | V |
| $\mathrm{V}_{\mathrm{CC}}$ <br> $(1$ minute max $)$ | Supply Voltage | 15 | mA |
| $\mathrm{I}_{\mathrm{O}}$ | Output Current (each channel) | 7.0 | V |
| $\mathrm{~V}_{\mathrm{O}}$ | Output Voltage (each channel) | 85 | mW |
| $\mathrm{P}_{\mathrm{O}}$ | Collector Output Power Dissipation |  |  |

## Recommended Operating Conditions

| Symbol | Parameter | Min. | Max. | Units |
| :---: | :--- | :---: | :---: | :---: |
| $\mathrm{I}_{\mathrm{FL}}$ | Input Current, Low Level | 0 | 250 | $\mu \mathrm{~A}$ |
| $\mathrm{I}_{\mathrm{FH}}$ | Input Current, High Level | $6.3^{(2)}$ | 15 | mA |
| $\mathrm{~V}_{\mathrm{CC}}$ | Supply Voltage, Output | 2.7 | 3.3 | V |
| $\mathrm{~T}_{\mathrm{A}}$ | Operating Temperature | -40 | +85 | ${ }^{\circ} \mathrm{C}$ |
| N | Fan Out (TTL load) | - | 5 | TTL Loads |
| $\mathrm{R}_{\mathrm{L}}$ | Output Pull-up | 330 | 4 K | $\Omega$ |

## Note:

2. 6.3 mA is a guard banded value which allows for at least $20 \%$ CTR degradation. Initial input current threshold value is 5.0 mA or less

Electrical Characteristics ( $\mathrm{T}_{\mathrm{A}}=-40^{\circ} \mathrm{C}$ to $+85^{\circ} \mathrm{C}$ Unless otherwise specified.)
Individual Component Characteristics

| Symbol | Parameter | Test Conditions | Min. | Typ. ${ }^{(3)}$ | Max. | Unit |
| :---: | :---: | :---: | :---: | :---: | :---: | :---: |
| EMITTER |  |  |  |  |  |  |
| $V_{F}$ | Input Forward Voltage | $\mathrm{I}_{\mathrm{F}}=10 \mathrm{~mA}$ | - | - | 1.8 | V |
|  |  | $\mathrm{T}_{\mathrm{A}}=25^{\circ} \mathrm{C}$ | - | - | 1.75 |  |
| $\mathrm{B}_{\mathrm{VR}}$ | Input Reverse Breakdown Voltage | $\mathrm{I}_{\mathrm{R}}=10 \mu \mathrm{~A}$ | 5.0 | - | - | V |
| $\Delta \mathrm{V}_{\mathrm{F}} / \Delta \mathrm{T}_{\mathrm{A}}$ | Input Diode Temperature Coefficient | $\mathrm{I}_{\mathrm{F}}=10 \mathrm{~mA}$ | - | -1.5 | - | $\mathrm{mV} /{ }^{\circ} \mathrm{C}$ |
| DETECTOR |  |  |  |  |  |  |
| $\mathrm{I}_{\mathrm{CCH}}$ | High Level Supply Current | $\mathrm{I}_{\mathrm{F}}=0 \mathrm{~mA}, \mathrm{~V}_{\mathrm{CC}}=3.3 \mathrm{~V}$ | - | 7.1 | 10 | mA |
| $\mathrm{I}_{\mathrm{CCL}}$ | Low Level Supply Current | $\mathrm{I}_{\mathrm{F}}=10 \mathrm{~mA}, \mathrm{~V}_{\mathrm{CC}}=3.3 \mathrm{~V}$ | - | 6.7 | 15 | mA |

Switching Characteristics $\left(\mathrm{T}_{\mathrm{A}}=-40^{\circ} \mathrm{C}\right.$ to $+85^{\circ} \mathrm{C}, \mathrm{V}_{\mathrm{CC}}=3.3 \mathrm{~V}, \mathrm{I}_{\mathrm{F}}=7.5 \mathrm{~mA}$ Unless otherwise specified.)

| Symbol | AC Characteristics | Test Conditions | Min. | Typ. ${ }^{(3)}$ | Max. | Unit |
| :---: | :---: | :---: | :---: | :---: | :---: | :---: |
| $\mathrm{T}_{\text {PLH }}$ | Propagation Delay Time to Output High Level | $\begin{aligned} & \mathrm{R}_{\mathrm{L}}=350 \Omega, \mathrm{C}_{\mathrm{L}}=15 \mathrm{pF} \\ & \text { Note 4, Fig. } 10 \end{aligned}$ | - | - | 90 | ns |
| $\mathrm{T}_{\text {PHL }}$ | Propagation Delay Time to Output Low Level | $\begin{aligned} & \mathrm{R}_{\mathrm{L}}=350 \Omega, \mathrm{C}_{\mathrm{L}}=15 \mathrm{pF} \\ & \text { Note 5, Fig. } 10 \end{aligned}$ | - | - | 75 | ns |
| $\left.\right\|^{\text {PHLL }}{ }^{-T_{\text {PLH }}}{ }^{\prime}$ | Pulse Width Distortion | $\begin{aligned} & \mathrm{R}_{\mathrm{L}}=350 \Omega, \mathrm{C}_{\mathrm{L}}=15 \mathrm{pF} \\ & \text { Fig. } 10 \end{aligned}$ | - | - | 25 | ns |
| $\mathrm{t}_{\mathrm{r}}$ | Output Rise Time (10-90\%) | $\begin{aligned} & \left.\mathrm{R}_{\mathrm{L}}=350 \Omega, \mathrm{C}_{\mathrm{L}}=15 \mathrm{pF}\right) \\ & \text { Note 6, Fig. } 10 \end{aligned}$ | - | 16 | - | ns |
| $\mathrm{t}_{\mathrm{f}}$ | Output Fall Time (90-10\%) | $\begin{aligned} & \mathrm{R}_{\mathrm{L}}=350 \Omega, \mathrm{C}_{\mathrm{L}}=15 \mathrm{pF} \\ & \text { Note 7, Fig. } 10 \end{aligned}$ | - | 4 | - | ns |
| $\mathrm{ICM}_{\mathrm{H}}$ | Common Mode Transient Immunity (at Output High Level) | $\begin{aligned} & \mathrm{R}_{\mathrm{L}}=350 \Omega, \mathrm{~T}_{\mathrm{A}}=25^{\circ} \mathrm{C}, \mathrm{I}_{\mathrm{F}}=0 \mathrm{~mA}, \\ & \mathrm{~V}_{\mathrm{CC}}=3.3 \mathrm{~V}, \mathrm{~V}_{\mathrm{O} \text { (Min.) }}=2 \mathrm{~V} \\ & \mathrm{~V}_{\mathrm{CM}} \mathrm{I}=1,000 \mathrm{~V} \\ & \text { Notes 8,11, Fig. } 11 \end{aligned}$ | 25,000 | - | - | V/us |
| ICM ${ }^{\text {L }}$ | Common Mode Transient Immunity (at Output Low Level) | $\begin{aligned} & \mathrm{R}_{\mathrm{L}}=350 \Omega, \mathrm{~T}_{\mathrm{A}}=25^{\circ} \mathrm{C}, \mathrm{I}_{\mathrm{F}}=7.5 \mathrm{~mA}, \\ & \mathrm{~V}_{\mathrm{CC}}=3.3 \mathrm{~V}, \mathrm{~V}_{\mathrm{O}(\mathrm{Max} .)}=0.8 \mathrm{~V} \\ & \mathrm{VV}_{\mathrm{CM}}=1,000 \mathrm{~V} \\ & \text { Notes } 9,11, \text { Fig. } 11 \\ & \hline \end{aligned}$ | 25,000 | - | - | V/us |

Transfer Characteristics $\left(\mathrm{T}_{\mathrm{A}}=-40^{\circ} \mathrm{C}\right.$ to $+85^{\circ} \mathrm{C}$ Unless otherwise specified.)

| Symbol | DC Characteristics | Test Conditions | Min. | Typ. ${ }^{(3)}$ | Max. | Unit |
| :---: | :--- | :--- | :---: | :---: | :---: | :---: |
| $\mathrm{V}_{\mathrm{OL}}$ | Low Level Output Voltage | $\mathrm{V}_{\mathrm{CC}}=3.3 \mathrm{~V}, \mathrm{I}_{\mathrm{F}}=5 \mathrm{~mA}, \mathrm{I}_{\mathrm{OL}}=13 \mathrm{~mA}$ | - | - | 0.6 | V |
| $\mathrm{I}_{\mathrm{FT}}$ | Input Threshold Current | $\mathrm{V}_{\mathrm{CC}}=3.3 \mathrm{~V}, \mathrm{~V}_{\mathrm{O}}=0.6 \mathrm{~V}, \mathrm{I}_{\mathrm{OL}}=13 \mathrm{~mA}$ | - | - | 5 | mA |

Isolation Characteristics ( $\mathrm{T}_{\mathrm{A}}=-40^{\circ} \mathrm{C}$ to $+85^{\circ} \mathrm{C}$ Unless otherwise specified.)

| Symbol | Characteristics | Test Conditions | Min. | Typ. ${ }^{(3)}$ | Max. | Unit |
| :---: | :--- | :--- | :---: | :---: | :---: | :---: |
| $\mathrm{I}_{\mathrm{I}-\mathrm{O}}$ | Input-Output <br> Insulation Leakage Current | Relative humidity $=45 \%$ <br> $\mathrm{~T}_{\mathrm{A}}=25^{\circ} \mathrm{C}, \mathrm{t}=5$ sec. <br> $\mathrm{V}_{\mathrm{I}-\mathrm{O}}=3000 \mathrm{VDC}$, Note 10 | - | - | 1.0 | $\mu \mathrm{~A}$ |
| $\mathrm{~V}_{\mathrm{ISO}}$ | Withstand Insulation Test <br> Voltage | $\mathrm{R}_{\mathrm{H}}<50 \%, \mathrm{~T}_{\mathrm{A}}=25^{\circ} \mathrm{C}$ <br> $\mathrm{I}_{\mathrm{I}-\mathrm{O}} \leq 2 \mu \mathrm{~A}, \mathrm{t}=1 \mathrm{~min} .$, <br> Note 10 | 2500 | - | - | $\mathrm{V}_{\mathrm{RMS}}$ |
| $\mathrm{R}_{\mathrm{I}-\mathrm{O}}$ | Resistance (Input to Output) | $\mathrm{V}_{\mathrm{I}-\mathrm{O}}=500 \mathrm{~V}$, Note 10 | - | $10^{12}$ | - | $\Omega$ |
| $\mathrm{C}_{\mathrm{I}-\mathrm{O}}$ | Capacitance (Input to Output) | $\mathrm{f}=1 \mathrm{MHz}$, Note 10 | - | 0.6 | - | pF |

## Notes:

3. All typical values are at $\mathrm{V}_{\mathrm{CC}}=3.3 \mathrm{~V}, \mathrm{~T}_{\mathrm{A}}=25^{\circ} \mathrm{C}$ unless otherwise specified.
4. $\mathrm{t}_{\text {PLH }}$ - Propagation delay is measured from the 3.75 mA level on the HIGH to LOW transition of the input current pulse to the 1.5 V level on the LOW to HIGH transition of the output voltage pulse.
5. $\mathrm{t}_{\mathrm{PHL}}$ - Propagation delay is measured from the 3.75 mA level on the LOW to HIGH transition of the input current pulse to the 1.5 V level on the HIGH to LOW transition of the output voltage pulse.
6. $t_{r}$ - Rise time is measured from the $90 \%$ to the $10 \%$ levels on the LOW to HIGH transition of the output pulse.
7. $t_{f}$ - Fall time is measured from the $10 \%$ to the $90 \%$ levels on the HIGH to LOW transition of the output pulse.
8. $\mathrm{CM}_{\mathrm{H}}$ - The maximum tolerable rate of rise of the common mode voltage to ensure the output will remain in the high state (i.e., $\mathrm{V}_{\text {OUT }}>2.0 \mathrm{~V}$ ). Measured in volts per microsecond (V/ $/ \mathrm{s}$ ).
9. $\mathrm{CM}_{\mathrm{L}}$ - The maximum tolerable rate of fall of the common mode voltage to ensure the output will remain in the low output state (i.e., $\mathrm{V}_{\text {OUT }}<0.8 \mathrm{~V}$ ). Measured in volts per microsecond ( $\mathrm{V} / \mu \mathrm{s}$ ).
10. Device considered a two-terminal device: Pins 1,2,3 and 4 shorted together, and Pins 5,6,7 and 8 shorted together.
11. The power supply bypass capacitors must be no further than 3 mm from the leads of the optocoupler. A low inductance ground plane width of with $\leq 5 \mathrm{nHy}$ of series lead inductance is required.

## Typical Performance Curves

Fig. 1 Forward Current vs. Forward Voltage


Fig. 3 Low Level Output Current vs. Ambient Temperature


Fig. 2 High Level Output Current vs. Ambient Temperature


Fig. 4 Input Threshold Current vs. Temperature


Typical Performance Curves (Continued)
Fig. 5 Pulse Width Distortion vs. Ambient Temperature


Fig. 7 Propagation Delay vs. Ambient Temperature


Fig. 6 Propagation Delay vs. Pulse Input Current


Fig. 8 Rise and Fall Times vs. Ambient Temperature


## Typical Performance Curves (Continued)

Fig. 9 Low Level Output Voltage vs. Ambient Temperature


Fig. 10 Test Circuit and Waveforms for $t_{\text {PLH }}, t_{\text {PHL }}, t_{r}$ and $t_{f}$


Fig. 11 Test Circuit and Waveforms for Common Mode Transient Immunity


## Footprint

8-Pin Small Outline


## Ordering Information

| Option | Order Entry Identifier | Description |
| :---: | :--- | :--- |
| No Suffix | HCPL062N | Shipped in tubes (50 units per tube) |
| R1 | HCPL062NR1 | Tape and Reel (500 units per reel) |
| R2 | HCPL062NR2 | Tape and Reel (2500 units per reel) |

## Marking Information



## Carrier Tape Specification



Reflow Profile




#### Abstract

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